


<b>Search Notes</b>  	<b>Application/Control No.</b>  10580025	<b>Applicant(s)/Patent Under Reexamination</b>  RAMPINI ET AL.
	<b>Examiner</b>  Haidung D Nguyen	<b>Art Unit</b>  1796

SEARCHED			
Class	Subclass	Date	Examiner
252	181.2	12/5/08	\HN\
424	45, 47	12/5/08	\HN\

SEARCH NOTES		
Search Notes	Date	Examiner
inventors search in eDan and Palm	12/5/08	\HN\

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/H. D. N./  
Examiner, Art Unit 1796